

Technical Reference



P7380

8 GHz 5X/25X Differential Probe

071-1544-01

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General Safety Summary

Review the following safety precautions to avoid injury and prevent damage to this product or any products connected to it. To avoid potential hazards, use this product only as specified.

Only qualified personnel should perform service procedures.

While using this product, you may need to access other parts of the system. Read the *General Safety Summary* in other system manuals for warnings and cautions related to operating the system.

To Avoid Fire or Personal Injury

Connect and Disconnect Properly. Connect the probe output to the measurement instrument before connecting the probe to the circuit under test. Disconnect the probe input and the probe ground from the circuit under test before disconnecting the probe from the measurement instrument.

Observe All Terminal Ratings. To avoid fire or shock hazard, observe all ratings and markings on the product. Consult the product manual for further ratings information before making connections to the product.

Do not apply a potential to any terminal, including the common terminal, that exceeds the maximum rating of that terminal.

Do Not Operate Without Covers. Do not operate this product with covers or panels removed.

Avoid Exposed Circuitry. Do not touch exposed connections and components when power is present.

Do Not Operate With Suspected Failures. If you suspect there is damage to this product, have it inspected by qualified service personnel.

Do Not Operate in Wet/Damp Conditions.

Do Not Operate in an Explosive Atmosphere.

Keep Product Surfaces Clean and Dry.

Symbols and Terms

Terms in this Manual. These terms may appear in this manual:



WARNING. *Warning statements identify conditions or practices that could result in injury or loss of life.*



CAUTION. *Caution statements identify conditions or practices that could result in damage to this product or other property.*

Symbol on the Product. The following symbol may appear on the product:



Introduction

This manual discusses topics not covered or otherwise mentioned briefly in the *P7380 Probe User Manual*.

The following is a list of sections with brief explanations:

- Theory of Operation — Contains probe details not mentioned in the user manual.
- Reference — Contains information about differential measurements and how to increase measurement accuracy.
- Specifications — Contains warranted, typical, and nominal characteristics for the probe and probe tips.
- Performance Verification — Describes the procedures for verifying the warranted specifications.

Theory of Operation

This section discusses operating considerations and probing techniques. For more detailed information about differential measurements and common-mode rejection ratio (CMRR), see the *Reference* section on page 7.

The P7380 probe is optimized for high bandwidth; it is not a general purpose probe. The probe head and tips are miniaturized for electrical characteristics and access to dense circuitry, and must be handled carefully.



CAUTION. To prevent damage to the probe, use care when handling the probe. Rough or careless use can damage the probe.

Input Voltage Limits

The P7380 differential probe is designed to probe low-voltage circuits. Before probing a voltage, take into account the limits for maximum input voltage, the common-mode signal range, and the differential-mode signal range. For specific limits, see *Specifications* on page 11.

Maximum Input Voltage

The maximum input voltage is the maximum voltage to ground that the inputs can withstand without damaging the probe input circuitry.



CAUTION. To avoid damaging the inputs of the P7380 differential probe, do not apply more than ± 15 V (DC + peak AC) between each input or between the probe inputs and ground.

Common-Mode Signal Range

The common-mode signal range is the maximum voltage that you can apply to each input, with respect to earth ground, without saturating the probe input circuitry. A common-mode voltage that exceeds the common-mode signal range may produce an erroneous output waveform even when the differential-mode specification is met. For specifications, refer to page 11.

Differential-Mode Signal Range

The differential-mode signal range is the maximum voltage difference between the plus and minus inputs that the probe can accept without distorting the signal. The distortion from a voltage that is too large can result in a clipped or otherwise inaccurate measurement. For specifications, refer to page 11.

Common-Mode Rejection

The common-mode rejection ratio (CMRR) is the ability of a probe to reject signals that are common to both inputs. More precisely, CMRR is the ratio of the differential gain to the common-mode gain. The higher the ratio, the greater the ability to reject common-mode signals. For additional information about CMRR, see page 8.

Probing Techniques to Maximize CMRR

The common-mode rejection of the probe is highest when the probe is applied directly to the circuit with the Short Flex, Small Resistor Tip-Clip Assembly shown in Figure 1. This Tip-Clip Assembly achieves a high CMRR by minimizing the distance between the probe head and the signal source. However, some probing tasks are made easier using other accessories included with the probe.

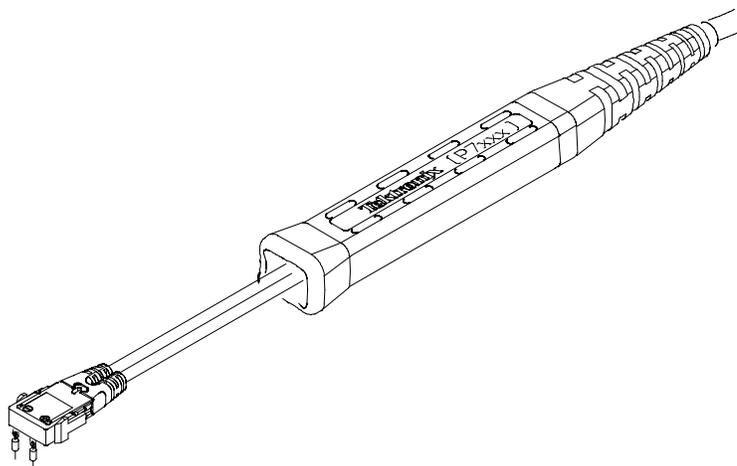


Figure 1: Use the Short Flex, Small Resistor Tip-Clip Assembly

Input Impedance and Probe Loading

When you connect the probe inputs to a circuit, you are introducing a new resistance, capacitance, and inductance into the circuit. Each input of the P7380 differential probe has a characteristic input impedance of $50\text{ k}\Omega$ to ground.

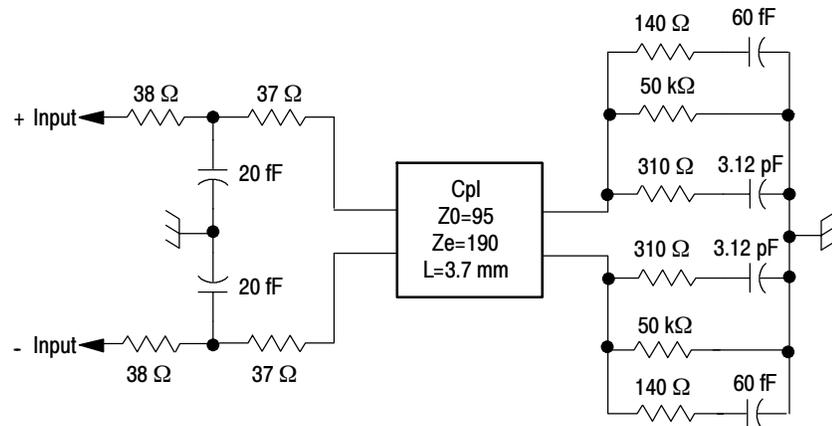


Figure 2: Typical probe input model

For signals with low source impedance and frequency, the $50\text{ k}\Omega$ input impedance on each input is large enough to prevent the inputs from loading the signal sources. As the signal source impedance on an input increases, the more the probe loads the source and reduces the signal amplitude. The greater the source impedances and the higher the signal frequencies, the more you must take these factors into account. See Figure 2.

The frequency of the signal also affects signal measurement. As the frequency of the signal increases, the input impedance of the probe decreases. The lower the impedance of the probe relative to that of the source, the more the probe loads the circuit under test and reduces the signal amplitude. For a graph of frequency versus input impedance, refer to Figure 4 on page 13.

Electrical Effects of Accessories

The Tip-Clip accessories included with your probe help connect to different types of components. The Tip-Clip accessories are designed to provide optimum performance as a system. Each Tip-Clip accessory has distinct characteristics. While these accessories make connections easier, be aware that the adapter you choose will affect the signal you are measuring, depending on a variety of factors, including signal frequency, source impedance, and lead length. Refer to the *Specification* section for more Tip-Clip information.

Reference

This section contains important reference information about differential measurements and how to increase measurement accuracy.

Single-Ended Measurements

A differential probe such as the P7380 can be used for single ended measurements within the limits of its dynamic and offset voltage ranges. Single-ended probes such as the P7260 typically have a wider offset range than corresponding differential probes (see Table 1).

Table 1: Offset ranges

Probe	DC Offset, 5X	Dynamic Range, 5X	DC Offset, 25X	Dynamic Range, 25X
P7260	+/- 5 V	1.5 V _{PP}	+/- 5 V	5 V _{PP}
P7380	+4 V, -3 V	1.25 V _{PP}	+4 V, -3 V	4 V _{PP}

Differential probes are ideal for a class of single ended measurements where the reference voltage is not ground such as:

- SSTL_{1,2}: $V_{TT}, V_{REF} = V_{DD}/2$
- PECL: $V_{REF} = V_{CC}-1.3$

To measure single-ended signals in this class connect the negative input of the P7380 to V_{REF} .

A differential probe in these applications displays the true signal despite any AC or DC variation in V_{REF} from its nominal value. While a single-ended probe displays the signal plus the variation in V_{REF} .

Differential Measurements

A differential probe does not need to be referenced to ground to overcome the signal-ended restrictions. To make a single ended measurement, connect one of the P7380 differential probe inputs to ground.

Devices designed for differential measurements avoid problems posed by single-ended systems. These devices include a variety of differential probes, differential amplifiers, and isolators.

The differential amplifier (Figure 3 on page 8), is used to make differential measurements that reject any voltage that is common to the inputs and amplifies any difference between the inputs. Voltage that is common to both inputs is often referred to as the Common-Mode Voltage (V_{CM}) and voltage that is different as the Differential-Mode Voltage (V_{DM}).

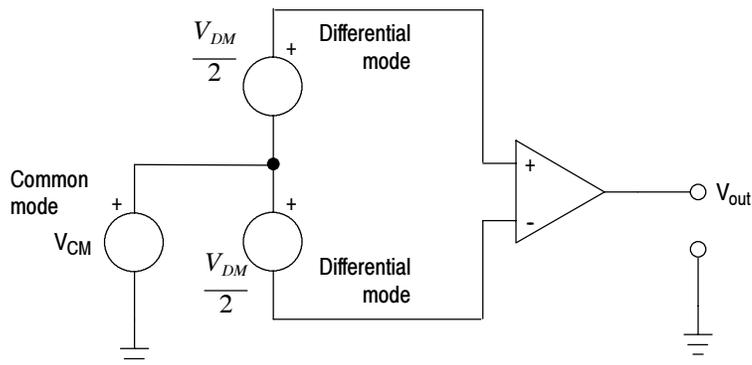


Figure 3: Simplified model of a differential amplifier

Common-Mode Rejection Ratio

Differential amplifiers cannot reject all of the common-mode signal. The ability of a differential amplifier to reject the common-mode signal is expressed as the Common-Mode Rejection Ratio (CMRR). The CMRR is the differential-mode gain (A_{DM}) divided by the common-mode gain (A_{CM}). It is expressed either as a ratio or in dB.

$$CMRR = \frac{A_{DM}}{A_{CM}} \quad dB = 20 \log \frac{A_{DM}}{A_{CM}}$$

CMRR generally is highest (best) at DC and degrades with increasing frequency.

Assessing CMRR Error

Figure 4 on page 13 shows the CMRR of the P7380 differential probe. This derating graph assumes a sinusoidal common-mode signal.

A quick way to assess the magnitude of CMRR error when the common-mode signal is not sinusoidal is to connect both leads to the same point in the circuit. The oscilloscope displays only the common-mode component that is not fully rejected by the probe. While this technique may not give you entirely accurate measurements, it does allow you to determine if the magnitude of the common-mode error signal is significant.

**Input Impedance Effects
on CMRR**

The lower the input impedance of the probe relative to the source impedance, the lower the CMRR for a given source impedance imbalance. Differences in the source impedance driving the two inputs lowers the CMRR.

Serial Bus Standards

Table 2 lists some popular high-speed data communication standards that can be measured with the P7380 differential probe.

Table 2: Serial bus standards with dynamic range requirements

Standard Data Rate	Vdm_max	Vdm_min	Vcm_max	Vcm_min
InfiniBand TX 2.5 Gb/s	1.6 V	1.0 V	1.0 V	0.5 V
InfiniBand RX 2.5 Gb/s	1.6 V	0.175 V	1.0 V	0.5 V
PCI Express TX 2.5 Gb/s	1.2 V	0.8 V	AC	AC
PCI Express RX 2.5 Gb/s	1.2 V	0.175 V	AC	AC
Serial ATA TX 1.5 Gb/s	0.6 V	0.4 V	0.3 V	0.2 V
Serial ATA RX 1.5 Gb/s	0.6 V	0.325 V	0.3 V	0.2 V
XAUI TX 3.125 Gb/s		0.4 V		
XAUI RX 3.125 Gb/s		0.1 V		
OIF-SxI-5 TX 3.125 Gb/s	1.0 V	0.5 V	1.23 V	0.72 V
OIF-SxI-5 RX 3.125 Gb/s	1.0 V	0.175 V	1.30 V	1.10 V
LV PECL (std ECL) >12GHz	1.66 V (typ)	1.48 V	1.3 V (vt)	0.5 V (vt)
LV PECL (RSECL) >12GHz	1.05 V	0.70 V	1.3 V (vt)	0.5 V (vt)

Specifications

The specifications in Tables 3 through 6 apply to P7380 differential probes installed on any TekConnect instrument or Tektronix 80A03 TekConnect adapter. When the probe is used with another oscilloscope, the oscilloscope must have an input impedance of 50 Ω . The probe must have a warm-up period of at least 20 minutes and be in an environment that does not exceed the limits described in Table 3. Specifications for the P7380 differential probe fall into three categories: warranted, typical, and nominal characteristics.

Warranted Characteristics

Warranted characteristics (Table 3) describe guaranteed performance within tolerance limits or certain type-tested requirements. Warranted characteristics that have checks in the *Performance Verification* section are marked with the ✓ symbol.

Table 3: Warranted electrical characteristics

Characteristic	Description
✓ DC attenuation accuracy	$\pm 2\%$
✓ Output Zero	± 3 mV (+20 to +30 °C, +68 to +86 °F) (5X) ± 15 mV on scope ± 10 mV (0 to +50 °C, +32 to +122 °F) (25X) ± 15 mV on scope
✓ Rise time	<55 ps (probe only, Short Flex, Small Resistor Tip-Clip), all other Tip-Clip assemblies are typical
Temperature	Operating: 0 to +40 °C (+32 to +104 °F), Nonoperating: -55 to +75 °C (-131 to +167 °F) ¹
Humidity	Operating: 0-90% RH, tested at +0 to +40 °C (+32 to +104 °F) Nonoperating: 0-90% RH, tested at -55 to +75 °C (+67 to +167 °F)

¹ See warning that follows.



WARNING. To avoid a burn hazard at high ambient temperatures, do not touch the probe with bare hands at nonoperating temperatures above +75 °C (+167 °F). Allow sufficient time for the probe to cool before handling.

Typical Characteristics

Typical characteristics (Tables 4 and 5) describe typical but not guaranteed performance.

Table 4: Typical electrical characteristics

Characteristic	Description
Differential input resistance, DC coupled	104 k Ω \pm 2%
Common-mode input resistance, DC coupled	52 k Ω \pm 1 k Ω
Differential offset range	-3.0 V to +4 V
Noise	< 31 nV/ $\sqrt{\text{Hz}}$ (5X), \leq 550 μ V RMS
	< 75 nV/ $\sqrt{\text{Hz}}$ (25X), \leq 275 μ V RMS
Input impedance	See Figure 5
Bandwidth	See <i>Tip-Clip assemblies</i> starting on page 16 for more detail information. (+ 2.0dB, -3 dB) for an ambient temperature range of 20 °C to 30 °C
Small signal rise time	See <i>Tip-Clip assemblies</i> starting on page 16 for more detail information. Ambient temperature range of 20 °C to 30 °C
Common-mode rejection ratio	See Figure 4 \leq 50 dB: DC — 1 MHz in 25X \leq 35 dB: >1 MHz — 800 MHz in 25X \leq 20 dB: >800 MHz — 8 GHz in 25X \leq 50 dB: DC — 1 MHz in 5X \leq 35 dB: >1 MHz — 800 MHz in 5X \leq 20 dB: >800 MHz — 8 GHz in 5X
Maximum non destructive input voltage	\pm 15 V _(DC + peak AC) between signal and common of the same channel
Differential signal range (DC coupled)	\pm 0.625 V at attenuation setting of 5X \pm 2.0 V at attenuation setting of 25X
Operating Voltage Window	-3.0 V to +4.0 V at (5X or 25X)
Linearity	\pm 0.25% over a dynamic range of -0.50 V to +0.50 V for 5X \pm 0.5% over a dynamic range of -1.6 V to +1.6 V for 25X
DC offset drift	150 μ V/ $^{\circ}$ C (at the output of the probe) 0.75 mV/ $^{\circ}$ C (displayed on screen with the TekConnect interface)
DC voltage measurement accuracy	\pm (2% of input + (2% of offset) + 50 mV + 7.5 mV) 5X \pm (2% of input + (2% of offset) + 50 mV + 40 mV) 25X

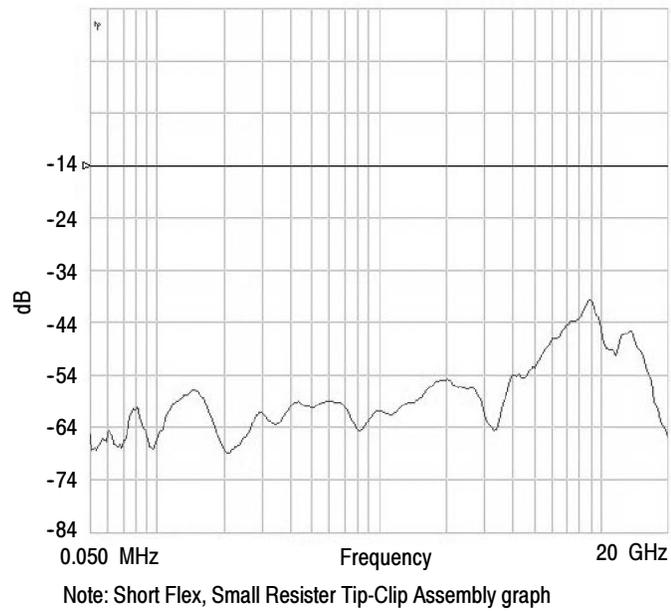


Figure 4: Typical Common-Mode Rejection Ratio (5X attenuation)

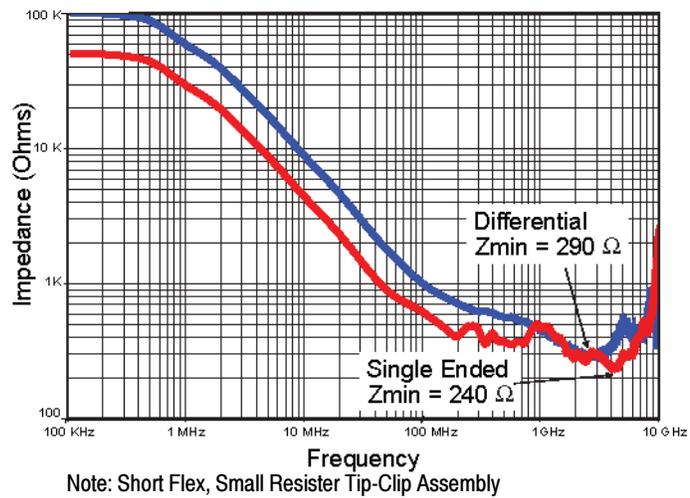


Figure 5: Typical differential input impedance verses frequency

Table 5: Typical mechanical characteristics

Characteristic	Description
Dimensions, compensation box	107 mm × 41 mm × 26 mm (4.2 in × 1.6 in × 1.0 in)
Dimensions, probe head	19.43 mm × 3.30 mm × 7.6 mm (0.765 in × 0.130 in × 0.300 in)
Dimensions, cable length	1.2 m (47 in) (from the probe head to the compensation box)
Unit weight	1.550 g (3.1 lbs) (probe, accessories and packaging)

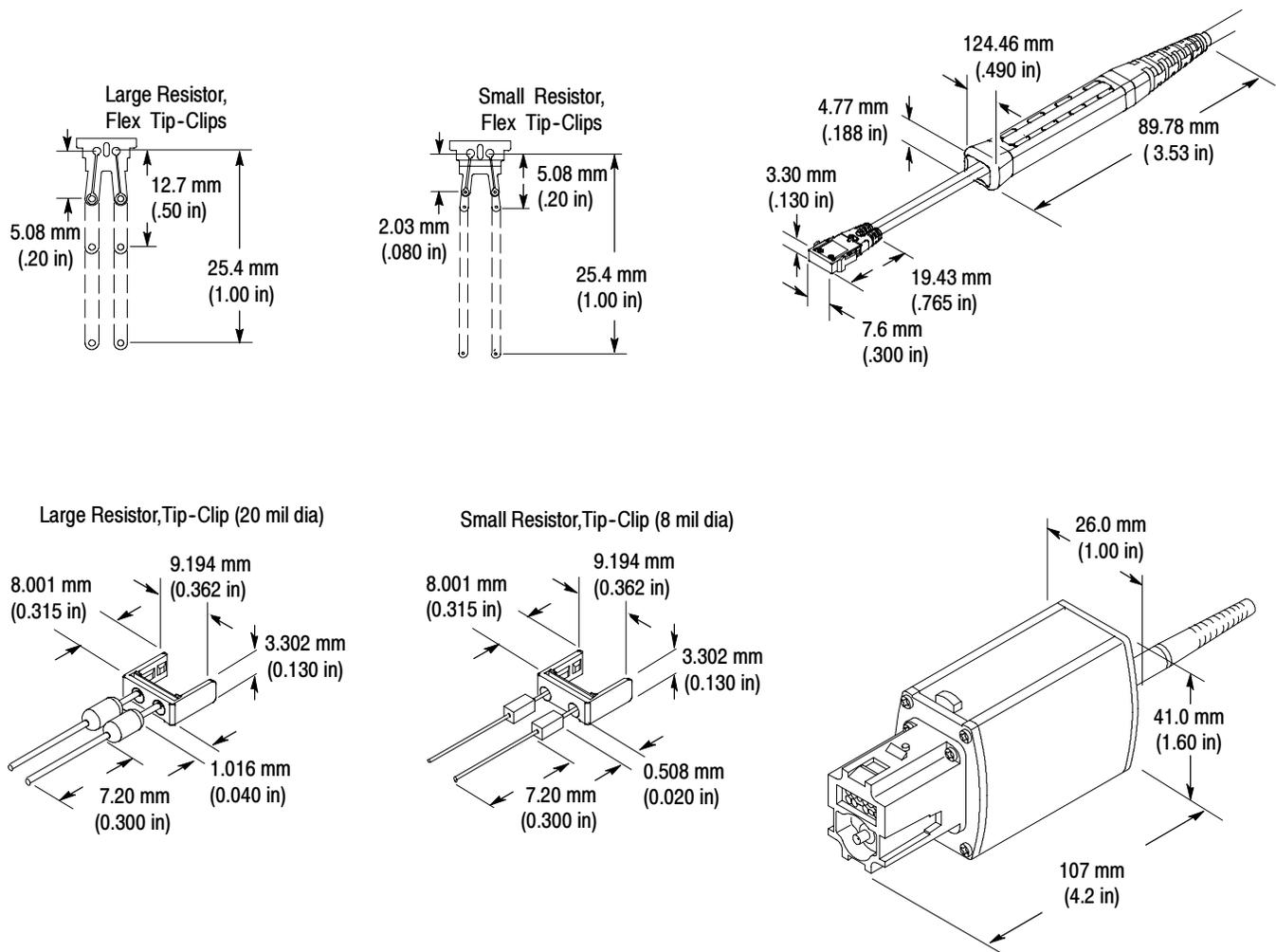


Figure 6: Probe and Tip-Clip dimensions

Nominal Characteristics

Nominal characteristics (Table 6) describe guaranteed traits, but the traits do not have tolerance limits.

Table 6: Nominal electrical characteristics

Characteristic	Description
Input configuration	Differential (two inputs, + and -), with case ground
Output coupling	DC
Attenuation settings	5X and 25X
Termination	Terminate output into 50 Ω

Tip-Clip Assembly Specifications

Note. All specs are typical in the following Tip-Clip assemblies, unless otherwise indicated.

Following are six flex Tip-Clip assemblies.

Short Flex, Small Resistor

Tektronix part number: 020-2600-XX

Bandwidth: >8.0 GHz

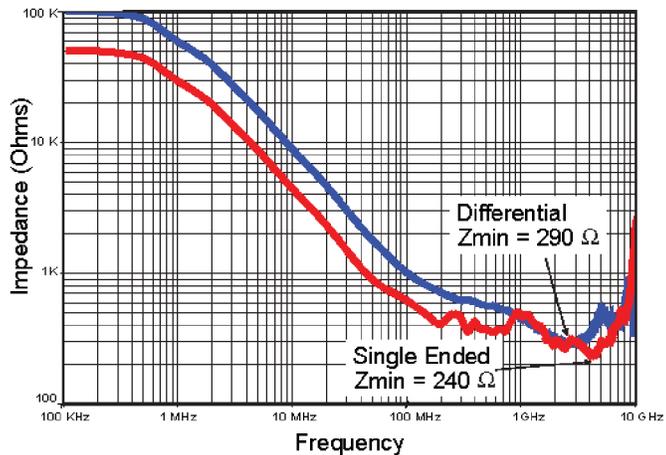
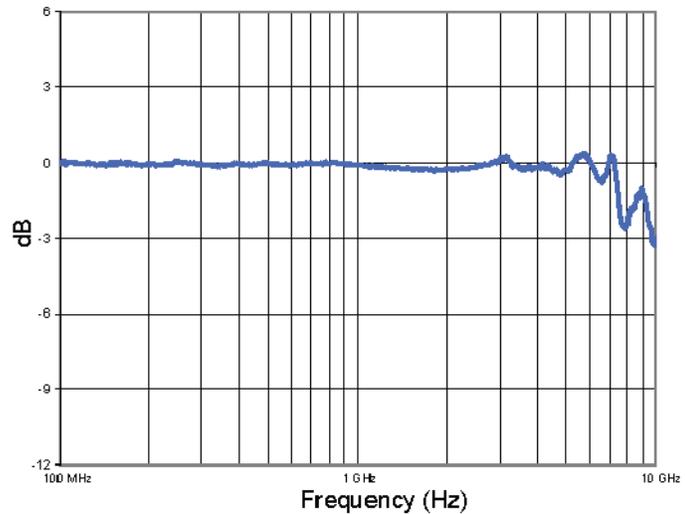
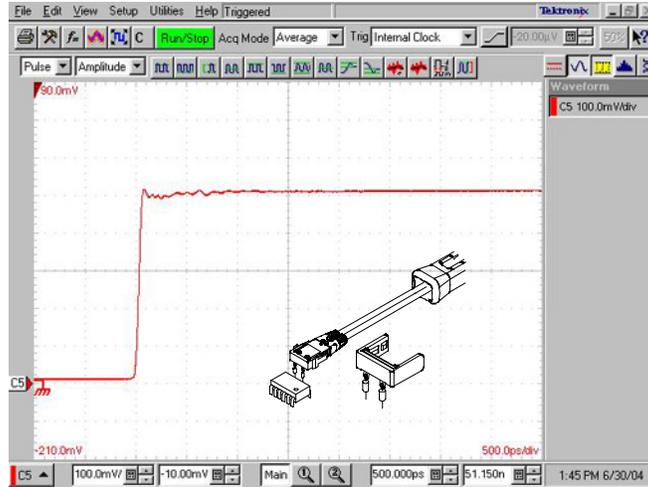
10/90 Rise time: <55 ps*

20/80 Rise time: <35 ps

*Guaranteed

Loading: Differential Z_{MIN} 290 Ω to 8 GHz

Best overall signal fidelity. The small resistors are ideal for connecting to small vias and fine pitch circuitry.



Short Flex, Large Resistor, 1/8 Watt

Tektronix part number: 020-2601-XX

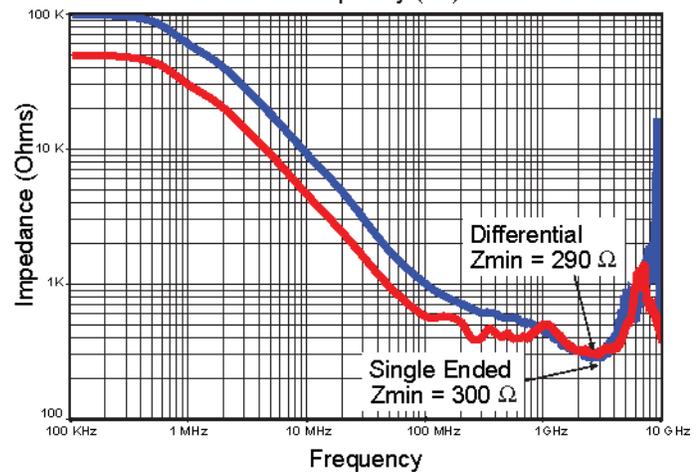
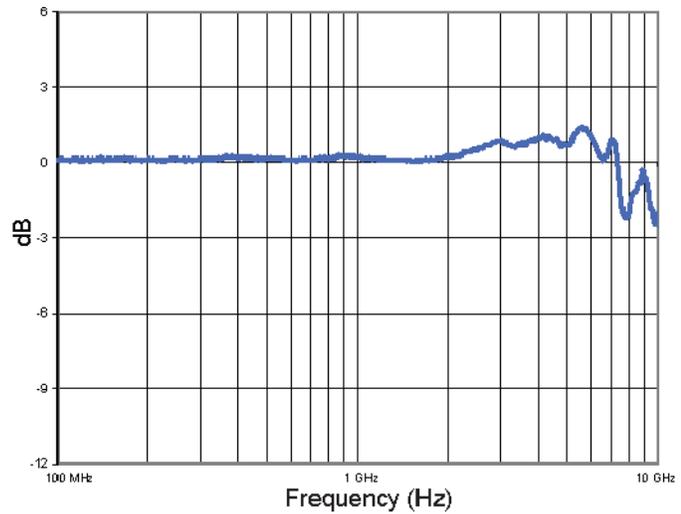
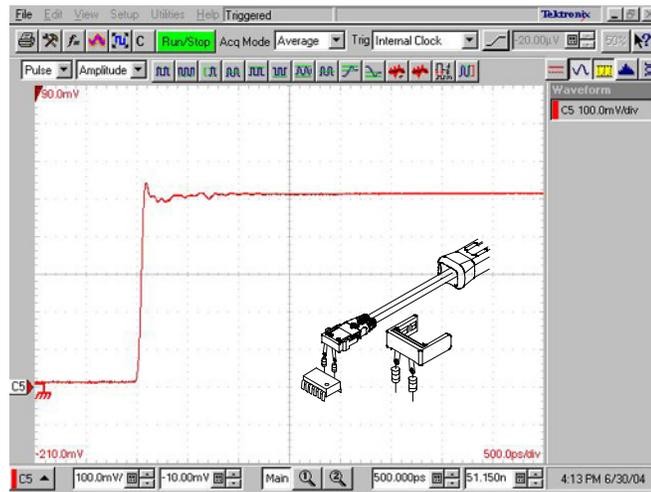
Bandwidth: >8.0 GHz

10/90 Rise time: <55 ps

20/80 Rise time: <35ps

Loading: Differential Z_{MIN} 290 Ω to
8 GHz

High bandwidth and good signal fidelity,
ideal for connecting to large components.



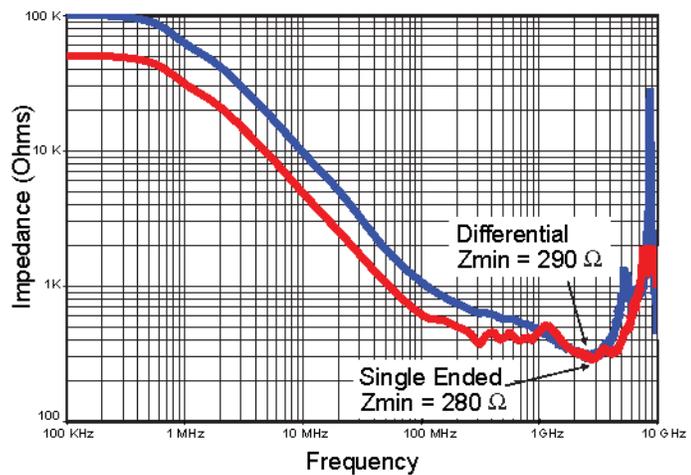
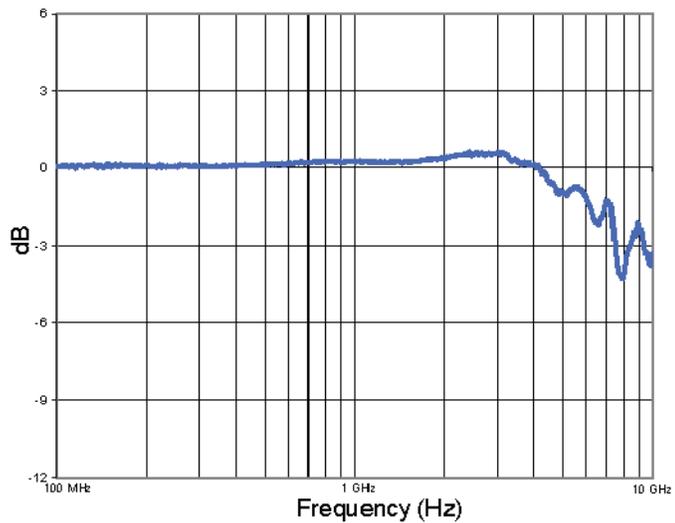
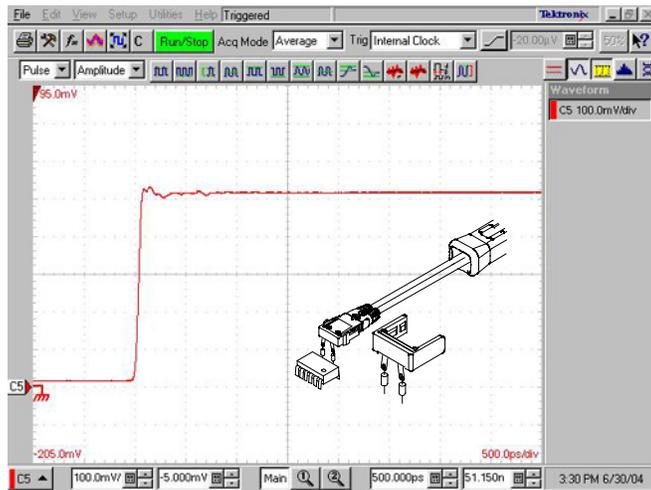
Medium Flex, Small Resistor

Tektronix part number: 020-2602-XX

Bandwidth: >7.0 GHz
 10/90 Rise time: <55 ps
 20/80 Rise time: <35ps

Loading: Differential Z_{MIN} 290 Ω to 8 GHz

Good compromise between ease-of-use and maximum performance when attaching to smaller devices or circuit board vias.



Medium Flex, Large Resistor, 1/8 Watt

Tektronix part number: 020-2603-XX

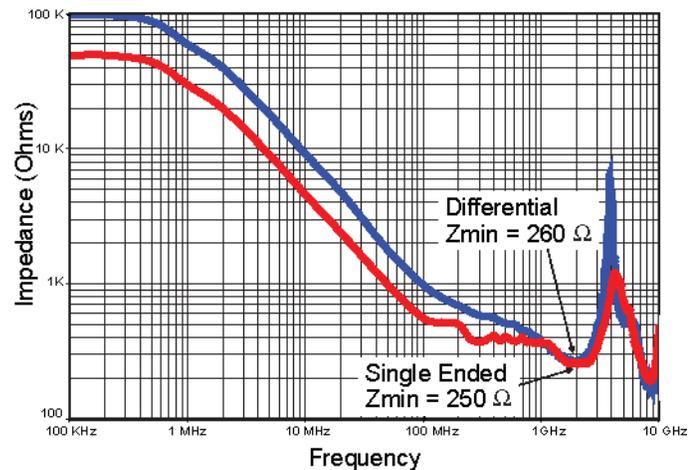
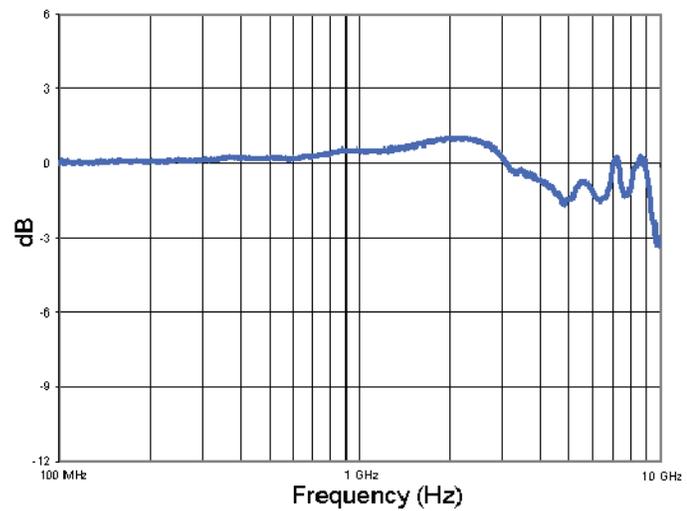
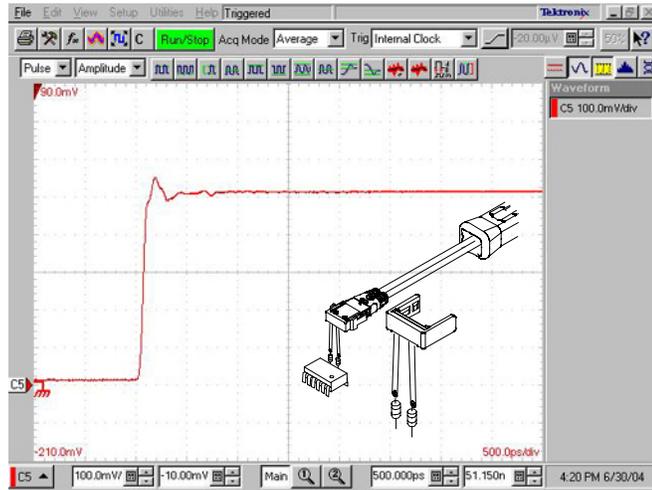
Bandwidth: >8.0 GHz

10/90 Rise time: <55 ps

20/80 Rise time: <35 ps

Loading: Differential Z_{MIN} 260 Ω to 8 GHz

Good compromise between ease-of-use and maximum performance when attaching to larger devices.



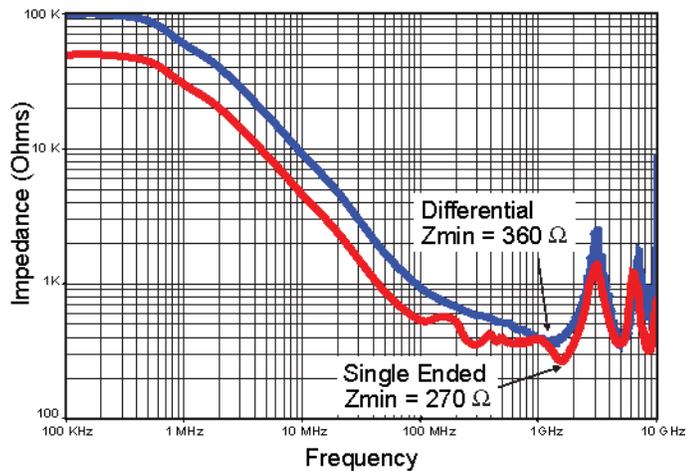
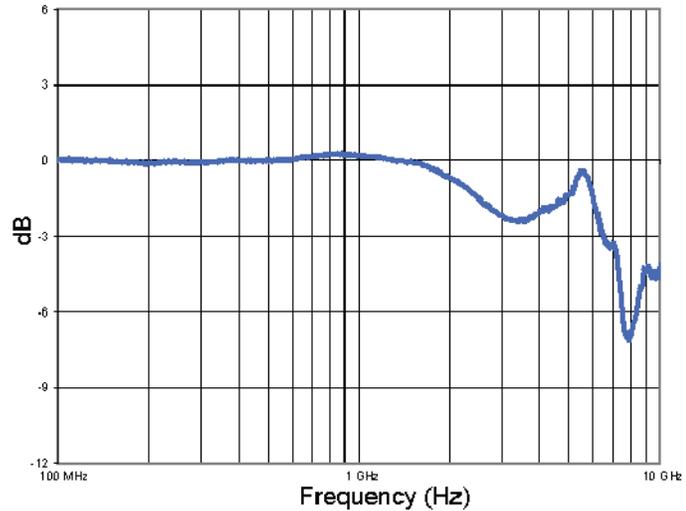
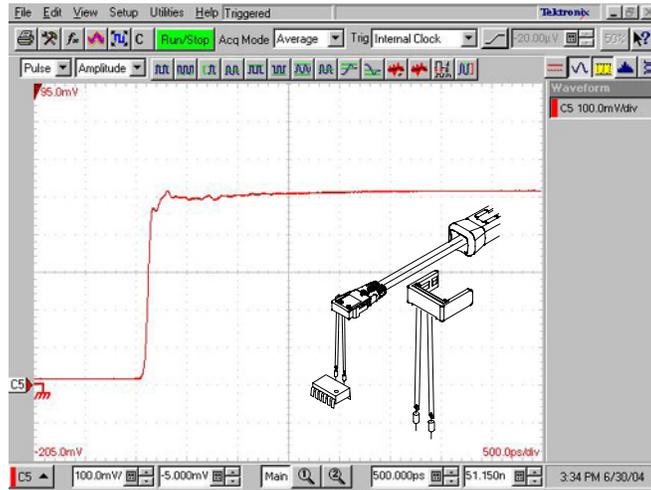
Long Flex, Small Resistor

Tektronix part number: 020-2604-XX

Bandwidth: >6.0 GHz
 10/90 Rise time: <130 ps
 20/80 Rise time: <40 ps

Loading: Differential Z_{MIN} 360 Ω to 8 GHz

Extended reach with good Step Response. Useful for connecting to hard to reach small vias and fine-pitch circuitry. Conveniently sized to fit between DIMM modules. Not recommended for signals faster than 4 GHz.

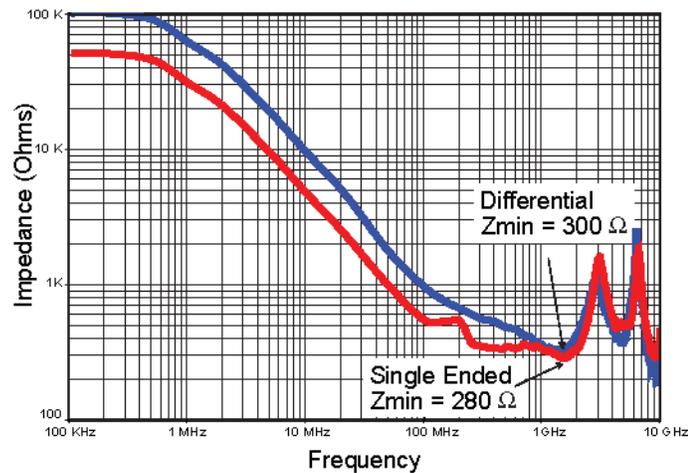
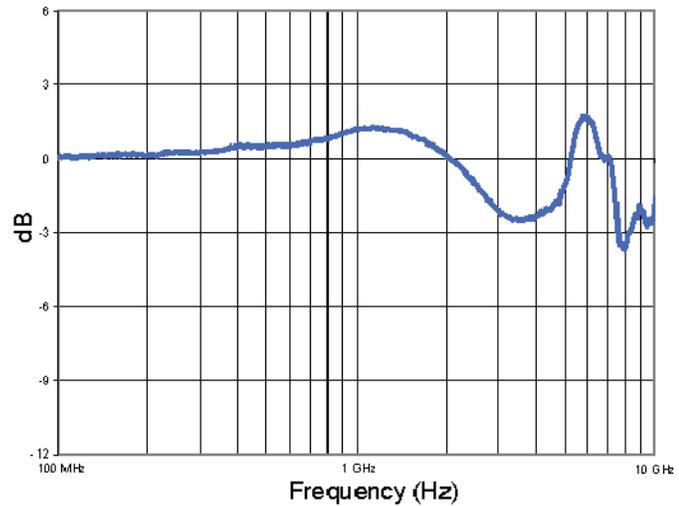
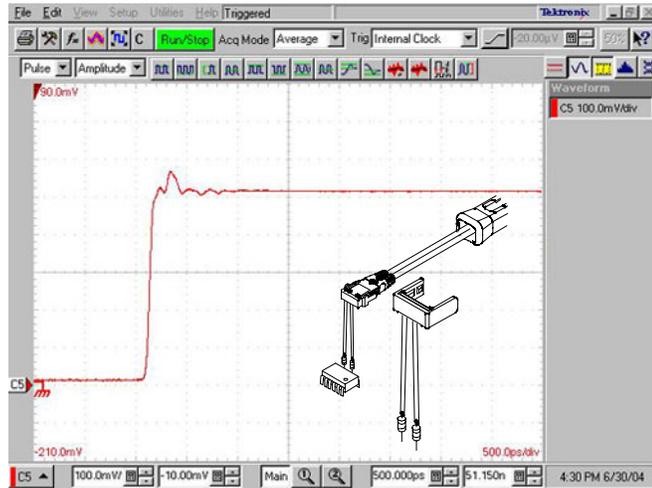


Long Flex, Large Resistor, 1/8 Watt
 Tektronix part number: 020-2605-XX

Bandwidth: >7.0 GHz
 10/90 Rise time: <75 ps
 20/80 Rise time: <40 ps

Loading: Differential Z_{MIN} 300 Ω to 8 GHz

Extended reach with good step response.
 Useful for connecting to hard-to-reach
 circuitry with large features. Conveniently
 sized to fit between DIMM modules. Not
 recommended for signals faster than
 4GHz.



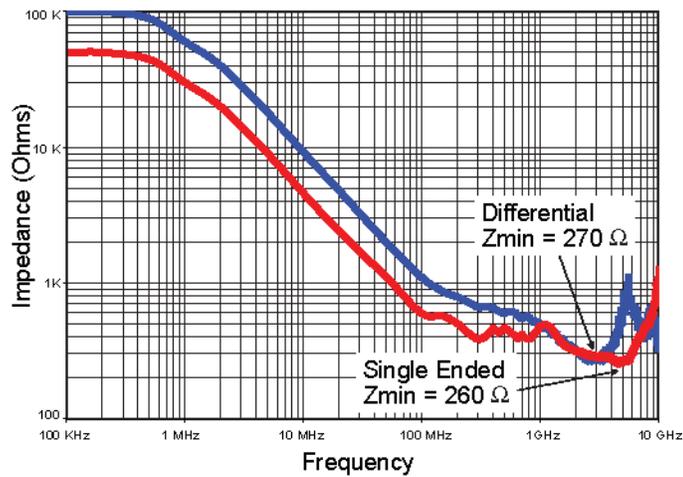
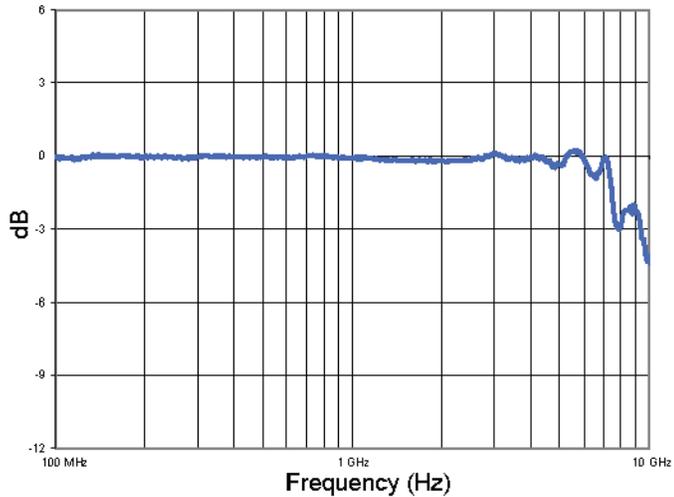
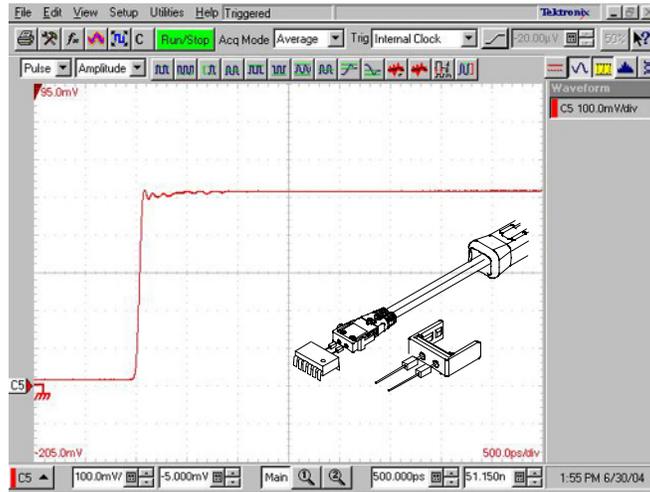
There are two resistor Tip-Clip assemblies. The resistor Tip-Clip assemblies provide differential interconnects out of the end of the Tip-Clip Assembly.

Small resistor, 1/16 watt, 8 mil dia
 Tektronix part number: 020-2599-XX

Bandwidth: >8.0 GHz
 10/90 Rise time: <55 ps
 20/80 Rise time: <35 ps

Loading: Differential Z_{MIN} 270 Ω to 8 GHz

Excellent signal fidelity. Similar to Short Flex, Small Resistor.



Large Resistor, 1/8 watt, 20 mil dia

Tektronix part number: 020-2598-XX

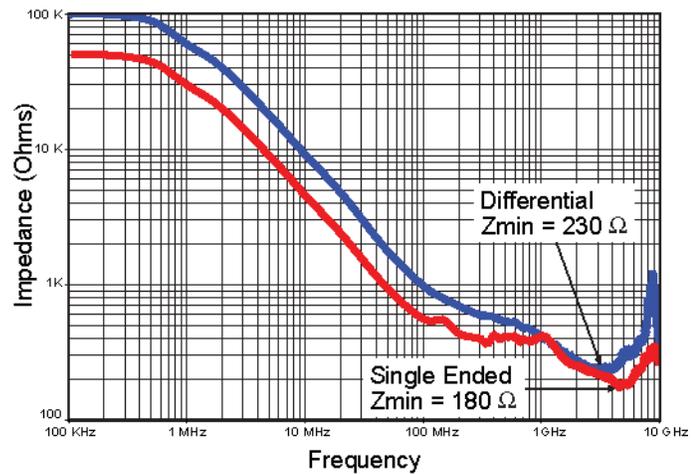
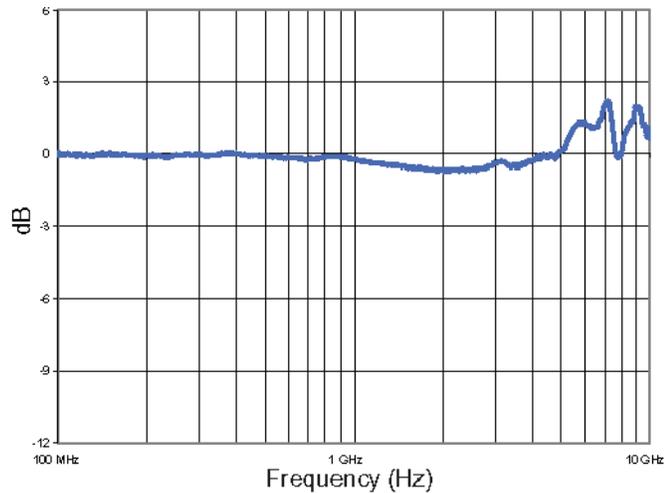
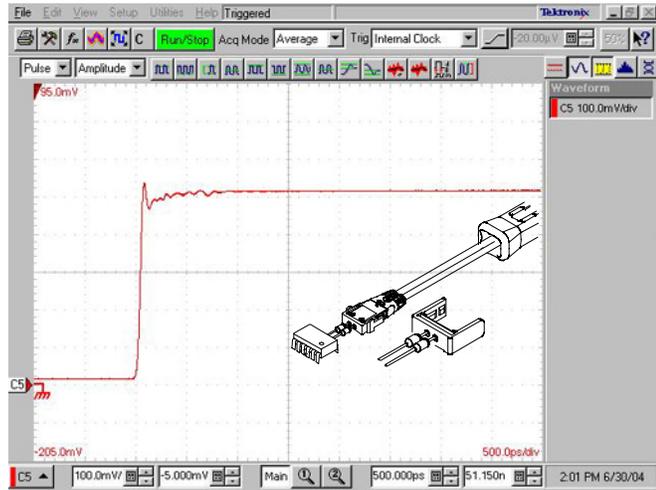
Bandwidth: >8.0 GHz

10/90 Rise time: <55 ps

20/80 Rise time: <35 ps

Loading: Differential Z_{MIN} 230 Ω to
8 GHz

Highest bandwidth and highest loading.
Performance similar to Short Flex, Large
Resistor, 1/8 Watt.



Variable Spacing Tip-Clip Assembly

Tektronix part number: 020-2596-XX

Optional Accessory, not included with the probe.

Bandwidth: >8 GHz[†]

T_R : 10/90 <55 ps[†], 20/80 <35 ps[†]

Loading[†]: Differential Z_{MIN} 190 Ω to 8 GHz

[†]Preliminary specification

Use the Variable Spacing Tip-Clip Assembly for probing test points spaced from 0.020-in to 0.180-in apart.

Exercise care when handling the articulated pins.

Performance Verification

The following procedures verify the warranted Output offset voltage, DC attenuation accuracy, and Rise time specifications of the P7380 Differential Probe. The recommended calibration interval is one year.



CAUTION. To avoid ESD damage to the probe, always use an antistatic wrist strap (provided with your probe), and work at a static-approved workstation when handling the probe.



Equipment Required

Table 7 lists the equipment required for the performance verification procedure. The types and quantities of connectors depends on the specific equipment you use.

Table 7: Test equipment

Description and quantity	Performance requirement	Recommended example ¹
Sampling Oscilloscope		Tektronix TDS8000
Sampling Module	20 GHz bandwidth	Tektronix 80E04
TekConnect Probe Interface Module with semi-rigid cable	Firmware version V:1.2 or 1.3	Tektronix 80A03, with 174-4857-XX cable
TekConnect-to-SMA adapter	See page 27	Tektronix TCA-SMA
DMM (2), with leads	0.1 mV and 0.01 Ω resolution	Fluke 187 or equivalent
Dual Power Supply	5.0 VDC at 200 mA	B+K Precision 1760A or equivalent
Coaxial cable	Male-to-Male SMA	174-1427-XX
Coaxial cable	Male-to-Male BNC, 50 Ω	012-0057-XX
Test leads (2)	Banana plug ends, red	012-0031-XX
Test leads (2)	Banana plug ends, black	012-0039-XX
Test leads (2)	Mini plunger with test clip	Mueller BU-1120
Adapter	SMA 50 Ω termination (comes with the probe calibration fixture)	015-1022-XX
Adapter	BNC(M)-to-Minigrabbers	013-0342-XX

Table 7: Test equipment (cont.)

Description and quantity	Performance requirement	Recommended example ¹
Adapter	SMA Male-to-BNC female	015-1018-XX
Adapter	SMA Male-to-Male	015-1011-XX
Feed through termination	BNC, 50 Ω \pm 0.05 Ω	011-0129-XX
Probe calibration fixture	See page 27	067-0419-XX
Probe Arm Adapter	See page 28	013-0339-XX
Short Flex, Small Resistor, Tip-Clip Assembly		020-2600-XX ²
Long Flex, Large Resistor, 1/8 Watt Tip-Clip Assembly		020-2605-XX ²
Super glue		Loktite444 12292
SMA torque wrench	5/16-in, 7 in-lb.	

¹ **Nine-digit part numbers (xxx-xxxx-xx) are Tektronix part numbers.**

² **Standard accessories included with the probe.**

- **Optional Tool.** A torque wrench helps to ensure reliable connections by meeting the nominal torque values listed in these instructions.

Special Adapters Required

Some of the adapters listed in Table 7 are available only from Tektronix. These adapters are described on the following pages.

TekConnect-to-SMA Adapter

The TekConnect-to-SMA Adapter, Tektronix part number TCA-SMA, lets you connect an SMA cable or probe to a TekConnect input. See Figure 7. Connect and disconnect the adapter the same way as you do the probe.

This adapter is an oscilloscope accessory that can be used for measurement applications, as well as these performance verification procedures.

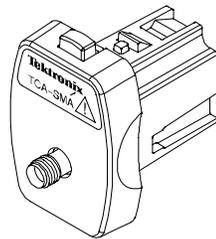


Figure 7: TekConnect-to-SMA Adapter

Probe Calibration Fixture

Some of the procedures in this manual use a probe calibration fixture, Tektronix part number 067-0419-XX.

The calibration fixture provides a means to test the probe for common mode (CM) and differential mode (DM) measurements. SMA connectors on the front and back of the fixture allow stimulus signals.

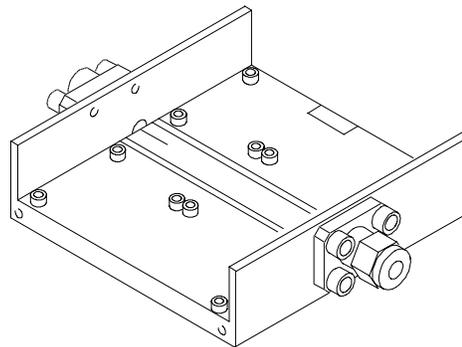


Figure 8: Probe Calibration Fixture

PPM203B Articulated Arm and Probe Arm Adapter

Some of the procedures in this manual use a PPM203B Articulated Arm. This is a general purpose benchtop probe holder that provides a method for securing the probe and must be used with the Probe Arm Adapter. Use the following steps and Figure 9 to attach the Probe Arm Adapter to the PPM203B Articulated Arm.

1. Using the Hex wrench, remove the screw from the end of the articulated arm.
2. Using the Hex wrench, attach the Adapter bottom to the probe arm.
3. Loosen the Adapter top by turning the two thumb screws counter clockwise.
4. Place the probe in the loosened Adapter bottom (keyed).
5. Secure the Adapter top by tightening the two thumb screws.

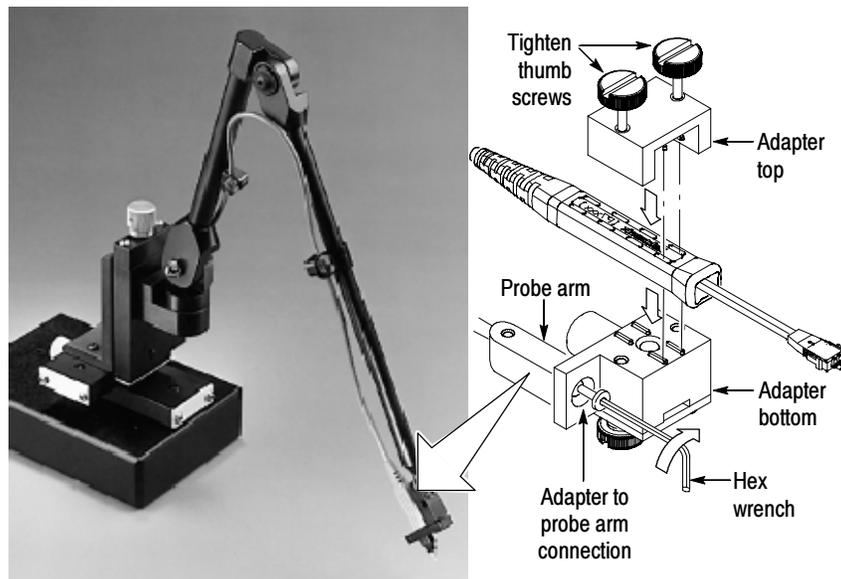


Figure 9: Adapter Fixture

Equipment Setup



CAUTION. To avoid ESD damage to the probe, always use an antistatic wrist strap (provided with your probe), and work at a static-approved workstation when handling the probe.



Perform the following verification procedures in order.

Use the following procedure to set up and warm the equipment to test the probe.

1. Connect the 80A03 TekConnect probe interface to channels 3 and 4 of the TDS8000 oscilloscope. See Figure 10.
2. Connect the 80E0X module to the 80A03 TekConnect probe interface.
3. Connect the probe to one of the 80A03 probe interface channels.
4. Turn on the oscilloscope and allow 20 minutes for the equipment to warm up.
5. From the Utilities menu, select Utilities Compensation.
6. Photocopy the test record on page 39 to record the performance test results.

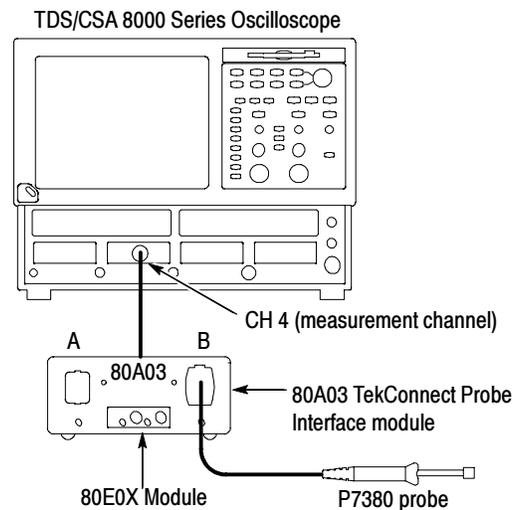


Figure 10: Preliminary test setup

NOTE. Before beginning these procedures, refer to page 39 and photocopy the test record and use it to record the performance test results.

Output Offset Voltage

Use the following procedure to test the Output Offset voltage.

1. Connect the equipment as shown in Figure 11.
2. Plug the probe into the 80A03 module.
3. Short the two Tip-Clip leads together (see Figure 11.) We recommend using the BNC(m)-to-Minigrabber (black).

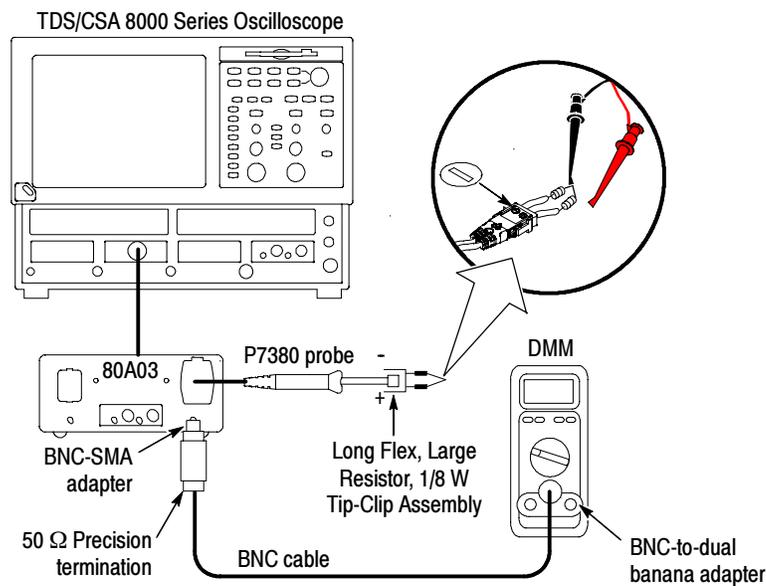


Figure 11: Setup for the output offset zero test

4. Set the multimeter to read DC volts.
5. Verify that the output voltage is 0 V, ± 10.0 mV for both the 5X and 25X attenuation settings.
6. Record the results on the test record.

DC Gain Accuracy

This test checks the DC gain accuracy of the probe at the 5X and 25X attenuation settings.

Gain Check at 5X Attenuation

1. Set the probe attenuation to 5X.
2. Connect the probe with a Tip-Clip Assembly to the power supply as shown in Figure 12. Monitor the source voltage with one of the DMMs.

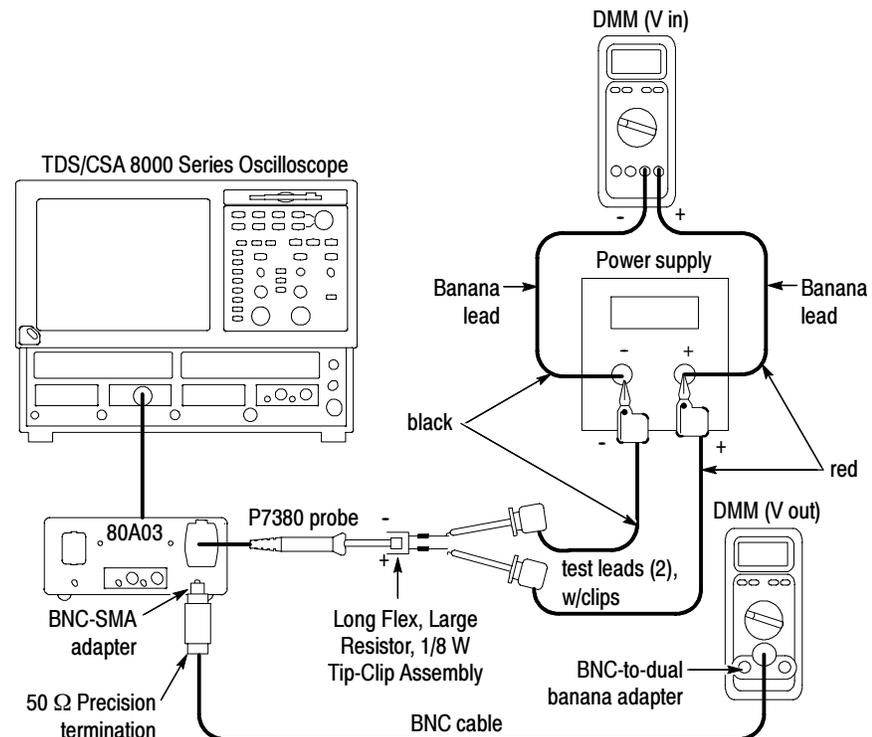


Figure 12: DC Gain Accuracy setup

3. Set the power supply to approximately +0.5 V. This represents 75% of the probe dynamic range in this attenuation setting. Record this source voltage as V_{in1} .
4. Record the output voltage (on the second DMM) as V_{out1} .
5. Disconnect the test leads from the power supplies. Leave the DMM leads connected to the adapters.
6. Reverse the polarity of the voltage applied to the probe inputs by swapping both sets of banana leads at the power supply, as shown in Figure 13.
7. Record the actual source voltage (now a negative value), as V_{in2} .

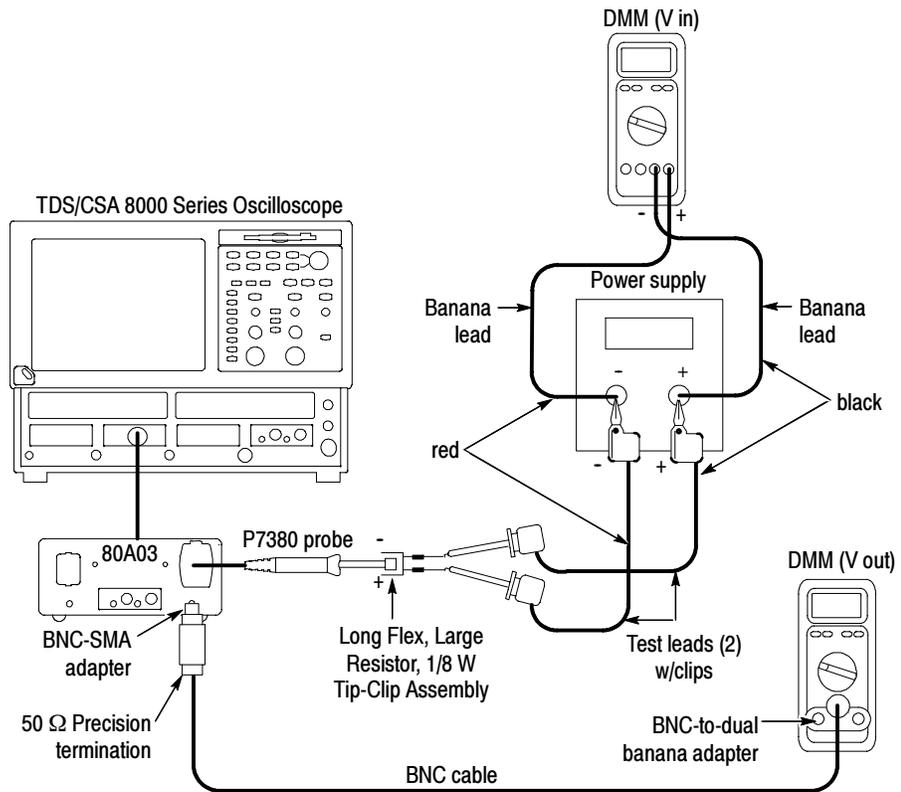


Figure 13: Reverse the power supply polarity on the probe inputs

8. Record the output voltage on the second DMM (now a negative value) as V_{out2} .
9. Calculate the gain as follows: $(V_{out1} - V_{out2}) \div (V_{in1} - V_{in2})$.
10. Verify that the gain is 0.2, $\pm 2.0\%$.
11. Record the calculated gain for the 5X setting on the test record.

Gain Check at 25X Attenuation

1. Set the attenuation on the probe to 25X.
2. Repeat steps 2 through 9, but in step 3, set the power supply to 1.5 V.
3. Verify that the gain is 0.04, $\pm 2.0\%$.
4. Record the calculated gain on the test record.

Rise Time

This procedure verifies that the probe meets the differential rise time specification. Two rise times are measured; the test system alone, and the test system with the probe included. The probe rise time is calculated using the two measurements.

This test uses the TDR function of the 80E04 sampling head as a fast rise time signal source and to take the measurements, using an 80A03 TekConnect probe interface. Although the following procedure assigns the TDR and measurement functions to specific oscilloscope channels, any valid channel combination can be used. However, the TDR function is only available on 80E04 sampling heads.

This test checks both of the probe attenuation settings.

Review *Using the Probe Calibration Fixture* on page 34 if you have not used a calibration fixture before.

Using the Probe Calibration Fixture

1. Connect the fixture to the test circuit using an SMA cable.
2. Connect the 50 Ω termination included with the fixture to the unused SMA connector.
3. Attach the probe to the probe calibration fixture (see Figure 14).
 - a. Attach a Short Flex, Small Resistor Tip-Clip Assembly to the probe head.
 - b. Trim both wire lengths to 0.050-inch.
 - c. On the surface of the probe calibration fixture, solder one lead to ground and one lead to the positive input. Solder the Tip-Clip leads from the end of the wire to the base of the resistor.
 - d. Use Tip-Clip Tape to attach the bottom of the Tip-Clip Assembly to the calibration fixture.

Quick Tip. For a quick calibration, leave a Short Flex, Small Resistor Tip-Clip assembly permanently attached (we recommend super glue) to the calibration fixture. You do not need to DC calibrate with a specific Tip-Clip Assembly.

NOTE. We recommend that you use the PPM203B Articulated Arm (see page 28) to stabilize the probe while verifying the differential rise time specification .

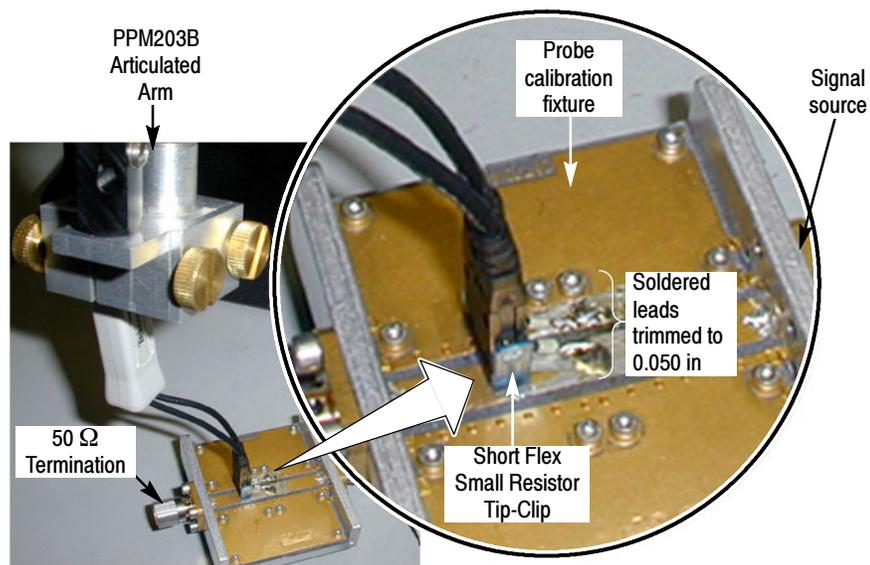


Figure 14: Probe Calibration Fixture and P7380 Probe

Rise Time Check at 25X Attenuation

1. Connect the test equipment as shown in Figure 15.

NOTE. To prevent mechanical strain on the connectors, use care when working with SMA connectors: Support equipment and use a torque wrench to tighten connections to 7 in-lbs.

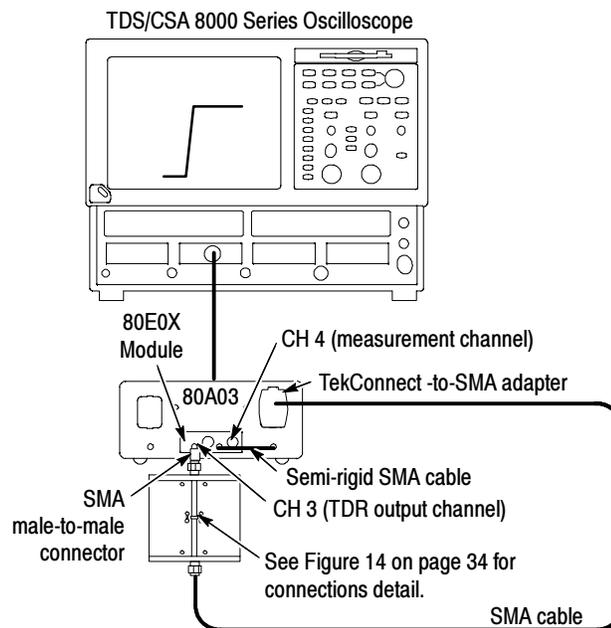


Figure 15: Test system rise time setup

NOTE. The 80A03 firmware version must be version V 1.2 or above. The firmware version label is on the rear panel of the instrument.

2. Turn on Channel 3 and 4, and set the vertical scale to 50 mV/div.
3. Set the Channel 3 sampling head to TDR mode:
Press the **SETUP DIALOGS** button and select the **TDR** tab. See Figure 16 on page 36.

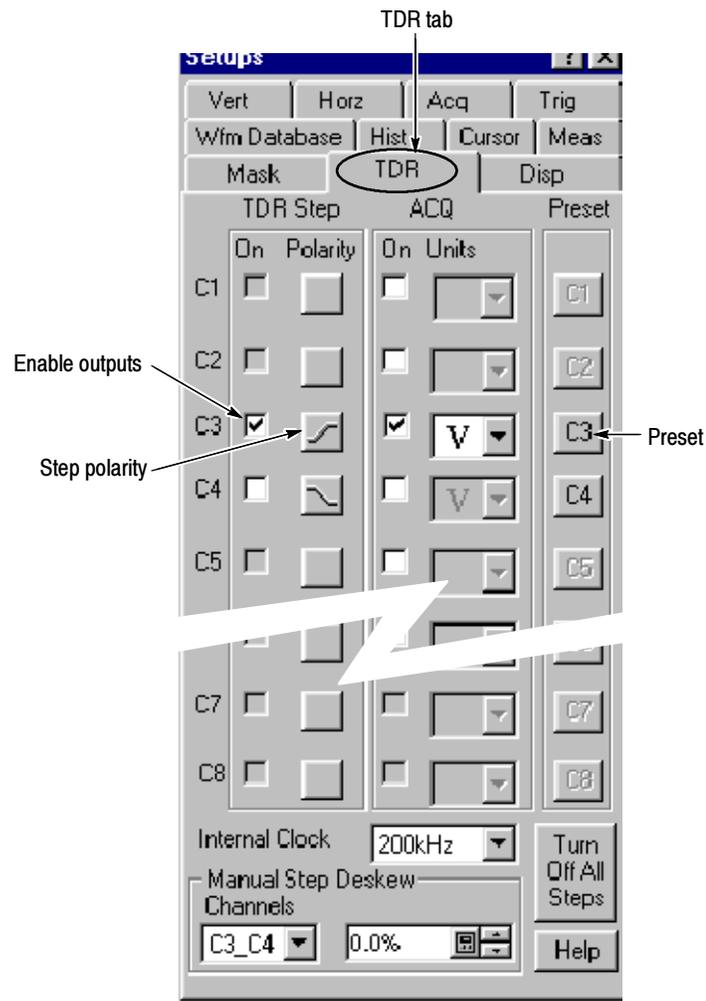


Figure 16: Setting the TDR parameters

4. Set the **Preset** of Channel 3. The sampling module turns on a red light next to the SELECT channel button, indicating that TDR is activated for that channel.

TDR Preset sets Internal Clock in the Trigger menu, turns on the TDR Step in the TDR Setups menu, turns on the channel and selects the acquisition Units in the TDR Setups menu, and sets the horizontal scale, position, and reference.

5. Turn off the display for Channel 3, then only Channel 4 is shown on the screen.
6. Adjust the oscilloscope horizontal and vertical position controls to display a signal similar to that shown in Figure 15.

7. Set the oscilloscope horizontal scale to 200 ps/div and center the waveform.
8. Use the oscilloscope measurement capability to display rise time. Increase the stability of the pulse edge measurement by using averaging, if available. Rise time is measured from the 10% and 90% amplitude points on the waveform. Record the system rise time as t_s . This value is used to calculate both the 5X and 25X probe rise times.

The following steps instruct you to assemble the test setup that includes the probe, as shown in Figure 17. The system and probe rise time (t_{s+p}) that you measure in step 16 is used to calculate the probe rise time (t_p) in step 17.

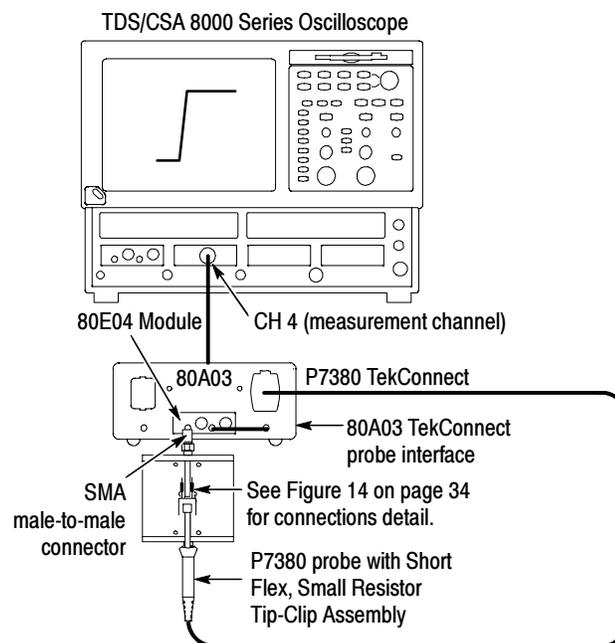


Figure 17: Test system rise time setup with probe

9. Connect the probe to the 80A03 TekConnect probe interface.
10. Connect the probe input to the probe calibration fixture as shown in Figure 14 on page 34.
11. Connect the SMA 50 Ω termination included with the probe calibration fixture to the open SMA input on the fixture.
12. Set the attenuation on the probe to 25X.

The test setup should now be connected as shown in Figure 17.

13. Expand the horizontal scale to help locate the step edge, then adjust the horizontal range to 20 ps/div while maintaining the edge view. For a more stable measurement display, turn averaging on.
14. Adjust the vertical scale to 50 mV/div, averaging on.
15. Adjust the horizontal positioning to place the rising edge of the signal on the second vertical and center horizontal graticule lines.
16. Use the oscilloscope measurement capability to display rise time. Rise time is determined from the 10% and 90% amplitude points on the waveform. Record the rise time as t_{s+p} .
17. Calculate the probe rise time using the following formula:

$$t_p = \sqrt{t_{(s+p)}^2 - t_s^2}$$

18. Record the calculated probe rise time on the test record.

**Rise Time Check at 5X
Attenuation**

19. Set the attenuation on the probe to 5X.
20. Repeat steps 13 through 18 for the 5X attenuation setting.

Test Record

Probe Model/Serial Number: _____ Certificate Number: _____
 Temperature: _____ RH %: _____
 Date of Calibration: _____ Technician: _____

Performance test	Minimum	Incoming	Outgoing	Maximum
Output offset voltage 25X ± 3 mV (20 °C to 30 °C)	- 3 mV			+ 3 mV
5X ± 3 mV (20 °C to 30 °C)	- 3 mV			+ 3 mV
DC attenuation accuracy 25X	0.0392			0.0408
5X	0.196			0.204
Rise time 25X	< 55 ps			N/A
5X	< 55 ps			N/A

Appendix A: User Service

This section covers troubleshooting and maintenance for the P7380 differential probe.

Probe/Adapter/Oscilloscope Compatibility

The P7380 differential probe is designed to work with all TekConnect-interface oscilloscopes and adapters. However, there may be some cases where all of the probe features may not work properly.

Table 8: P7380 probe compatibility issues

Symptom	Likely cause
P7380 probe does not work with an 80A03 TekConnect Probe Interface Adapter The LED on the 80A03 Adapter glows red, indicating an incompatible probe.	The 80A03 Adapter requires firmware version V1.2 or above. The firmware version label is on the rear panel of the instrument. Contact Tektronix for information on updating the adapter firmware.

Error Condition

The LEDs on the probe alert you to error or status conditions affecting the probe. If the probe LEDs flash or otherwise appear to be malfunctioning, an error condition may exist. Call your Tektronix representative for service.

When the probe is functioning correctly there is quick flash of the LEDs on the probe just after connecting to the oscilloscope.

Replacement Parts

There are no user replaceable parts within the probe. Refer to the *P7380 User Manual (071-1393-XX)* for a list of replaceable accessories for your probe.

If your probe does not meet the specifications tested in the Performance Verification, you can send the probe to Tektronix for repair. Follow the procedure below to prevent damage to the probe during shipping.

Preparation for Shipment

If the original packaging is unfit for use or not available, use the following packaging guidelines:

1. Use a corrugated cardboard shipping carton having inside dimensions at least one inch greater than the probe dimensions. The box should have a carton test strength of at least 200 pounds.
2. Put the probe into an antistatic bag or wrap to protect it from dampness.
3. Place the probe into the box and stabilize it with light packing material.
4. Seal the carton with shipping tape.
5. Refer to *Contacting Tektronix* at the front of the manual for the shipping address.